

# Automotive N-Channel 50 V (D-S) 175 °C MOSFET

PRODUCT SUMMARY	
$V_{DS}$ (V)	50
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 10$ V	0.011
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 4.5$ V	0.015
$I_D$ (A)	50
Configuration	Single

**FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- Package with Low Thermal Resistance
- Compliant to RoHS Directive 2002/95/EC
- AEC-Q101 Qualified<sup>d</sup>
- Find out more about Vishay's Automotive Grade Product Requirements at: [www.vishay.com/applications](http://www.vishay.com/applications)

**ORDERING INFORMATION**

Package	TO-252
Lead (Pb)-free and Halogen-free	SQD50N05-11L-GE3

**ABSOLUTE MAXIMUM RATINGS** ( $T_C = 25$  °C, unless otherwise noted)

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		$V_{DS}$	50	V
Gate-Source Voltage		$V_{GS}$	$\pm 20$	
Continuous Drain Current	$T_C = 25$ °C <sup>a</sup>	$I_D$	50	A
	$T_C = 125$ °C		32	
Continuous Source Current (Diode Conduction) <sup>a</sup>		$I_S$	50	
Pulsed Drain Current <sup>b</sup>		$I_{DM}$	200	
Single Pulse Avalanche Energy	$L = 0.1$ mH	$I_{AS}$	45	mJ
Single Pulse Avalanche Current		$E_{AS}$	101	
Maximum Power Dissipation <sup>b</sup>	$T_C = 25$ °C	$P_D$	75	W
	$T_C = 125$ °C		25	
Operating Junction and Storage Temperature Range		$T_J, T_{stg}$	- 55 to + 175	°C

**THERMAL RESISTANCE RATINGS**

PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount <sup>c</sup>	$R_{thJA}$	60	°C/W
Junction-to-Case (Drain)		$R_{thJC}$	2.0	

**Notes**

- Package limited.
- Pulse test; pulse width  $\leq 300$   $\mu$ s, duty cycle  $\leq 2$  %.
- When mounted on 1" square PCB (FR-4 material).
- Parametric verification ongoing.

# SQD50N05-11L



Vishay Siliconix "Supplier"

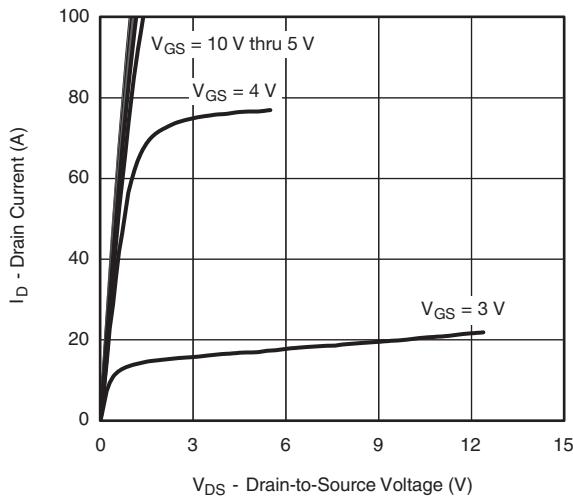
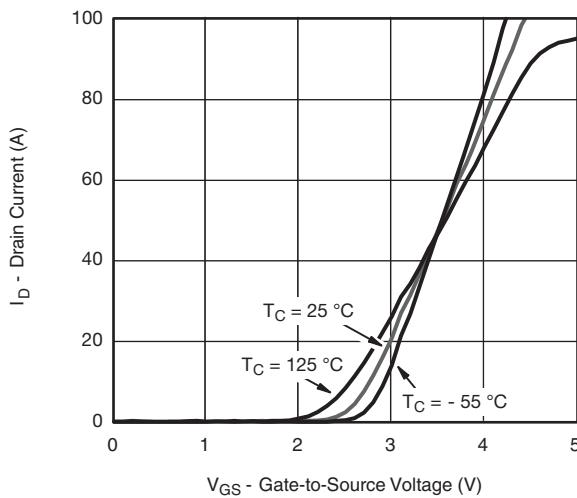
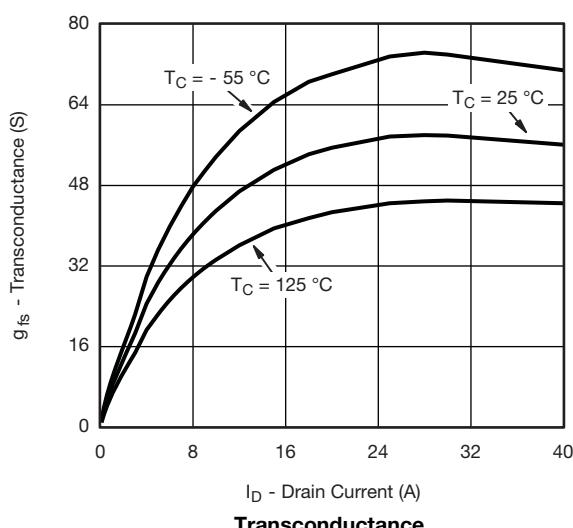
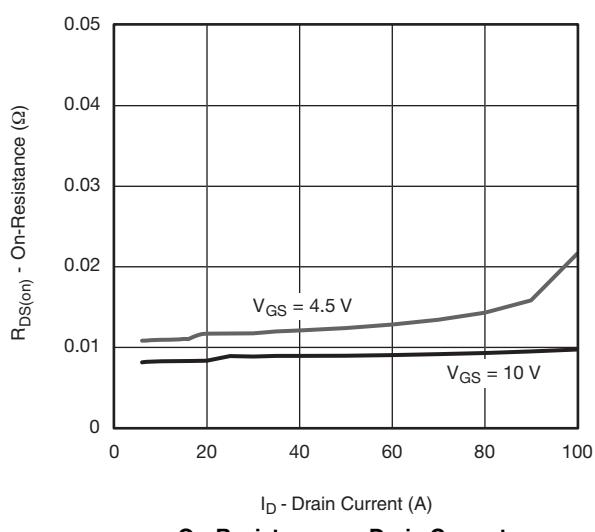
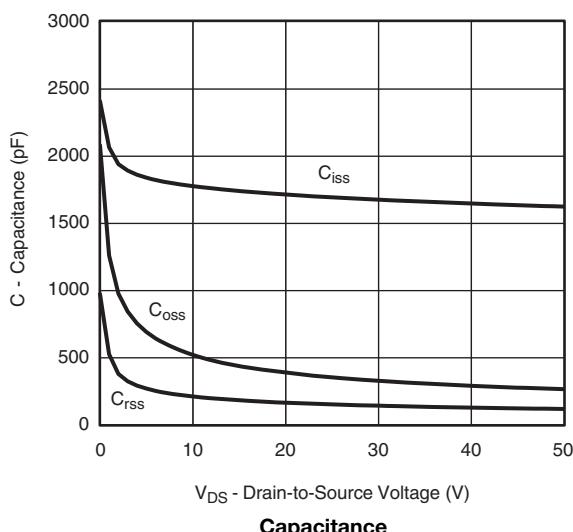
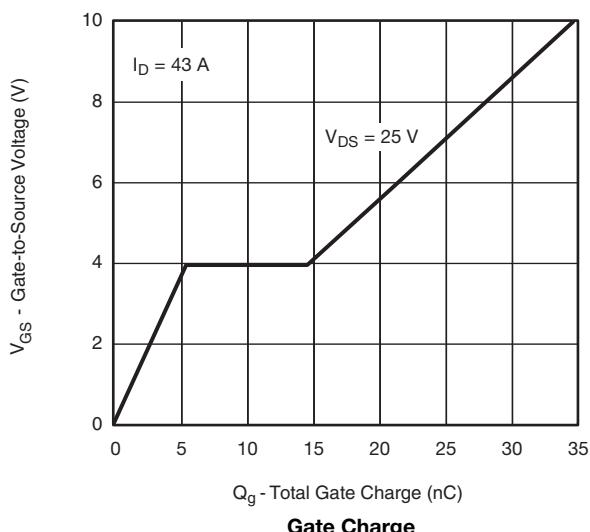
## SPECIFICATIONS ( $T_C = 25^\circ\text{C}$ , unless otherwise noted)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
<b>Static</b>								
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}$	$I_D = 250 \mu\text{A}$	50	-	-	V	
Gate-Source Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}$	$I_D = 250 \mu\text{A}$	1.5	2.0	2.5		
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0 \text{ V}$ , $V_{GS} = \pm 20 \text{ V}$		-	-	$\pm 100$	nA	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{GS} = 0 \text{ V}$	$V_{DS} = 50 \text{ V}$	-	-	1.0	$\mu\text{A}$	
		$V_{GS} = 0 \text{ V}$	$V_{DS} = 50 \text{ V}$ , $T_J = 125^\circ\text{C}$	-	-	50		
		$V_{GS} = 0 \text{ V}$	$V_{DS} = 50 \text{ V}$ , $T_J = 175^\circ\text{C}$	-	-	250		
On-State Drain Current <sup>a</sup>	$I_{D(\text{on})}$	$V_{GS} = 10 \text{ V}$	$V_{DS} \geq 5 \text{ V}$	50	-	-	A	
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}$	$I_D = 45 \text{ A}$	-	0.009	0.011	$\Omega$	
		$V_{GS} = 10 \text{ V}$	$I_D = 45 \text{ A}$ , $T_J = 125^\circ\text{C}$	-	-	0.020		
		$V_{GS} = 10 \text{ V}$	$I_D = 45 \text{ A}$ , $T_J = 175^\circ\text{C}$	-	-	0.024		
		$V_{GS} = 4.5 \text{ V}$	$I_D = 45 \text{ A}$	-	-	0.015		
Forward Transconductance <sup>b</sup>	$g_{fs}$	$V_{DS} = 15 \text{ V}$ , $I_D = 30 \text{ A}$		-	58	-	S	
<b>Dynamic<sup>b</sup></b>								
Input Capacitance	$C_{iss}$	$V_{GS} = 0 \text{ V}$	$V_{DS} = 25 \text{ V}$ , $f = 1 \text{ MHz}$	-	1685	2106	$\text{pF}$	
Output Capacitance	$C_{oss}$			-	345	430		
Reverse Transfer Capacitance	$C_{rss}$			-	144	180		
Total Gate Charge <sup>c</sup>	$Q_g$	$V_{GS} = 10 \text{ V}$	$V_{DS} = 25 \text{ V}$ , $I_D = 43 \text{ A}$	-	34.6	52	$\text{nC}$	
Gate-Source Charge <sup>c</sup>	$Q_{gs}$			-	5.5	9		
Gate-Drain Charge <sup>c</sup>	$Q_{gd}$			-	9.1	14		
Turn-On Delay Time <sup>c</sup>	$t_{d(\text{on})}$			-	8.5	13		
Rise Time <sup>c</sup>	$t_r$	$V_{DD} = 25 \text{ V}$ , $R_L = 0.6 \Omega$ $I_D \geq 43 \text{ A}$ , $V_{GEN} = 10 \text{ V}$ , $R_g = 1 \Omega$				-	$\text{ns}$	
Turn-Off Delay Time <sup>c</sup>	$t_{d(\text{off})}$	$V_{DD} = 25 \text{ V}$ , $R_L = 0.6 \Omega$ $I_D \geq 43 \text{ A}$ , $V_{GEN} = 10 \text{ V}$ , $R_g = 1 \Omega$				-		
Fall Time <sup>c</sup>	$t_f$	$V_{DD} = 25 \text{ V}$ , $R_L = 0.6 \Omega$ $I_D \geq 43 \text{ A}$ , $V_{GEN} = 10 \text{ V}$ , $R_g = 1 \Omega$				-		
<b>Source-Drain Diode Ratings and Characteristics<sup>b</sup></b>								
Pulsed Current <sup>a</sup>	$I_{SM}$			-	-	200	A	
Forward Voltage	$V_{SD}$	$I_F = 45 \text{ A}$ , $V_{GS} = 0 \text{ V}$		-	0.95	1.5	V	

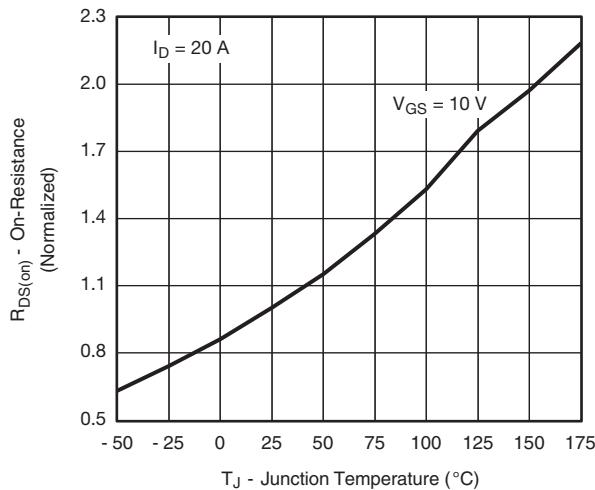
### Notes

- a. Pulse test; pulse width  $\leq 300 \mu\text{s}$ , duty cycle  $\leq 2\%$ .
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

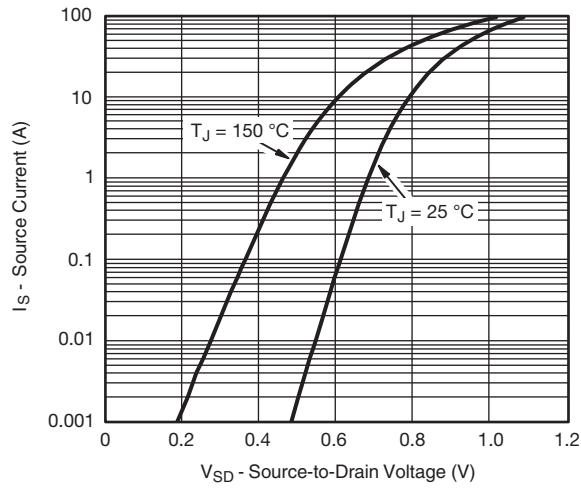
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)

**Output Characteristics**

**Transfer Characteristics**

**Transconductance**

**On-Resistance vs. Drain Current**

**Capacitance**

**Gate Charge**

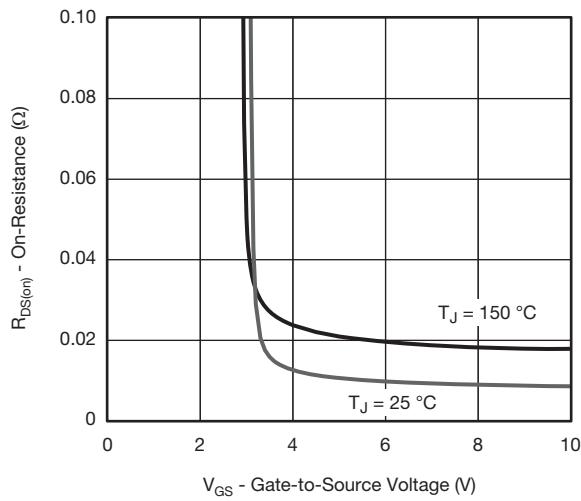
## TYPICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)



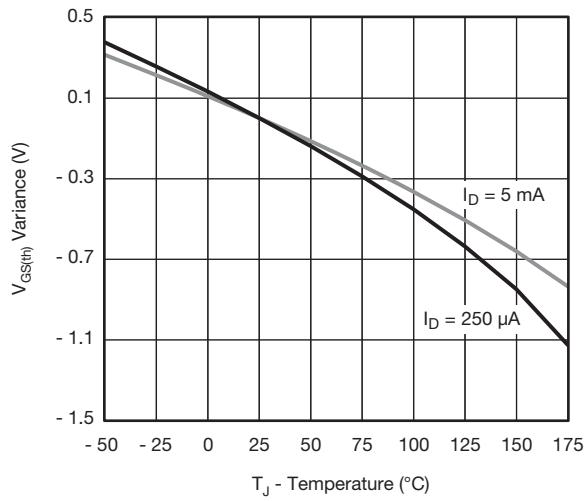
On-Resistance vs. Junction Temperature



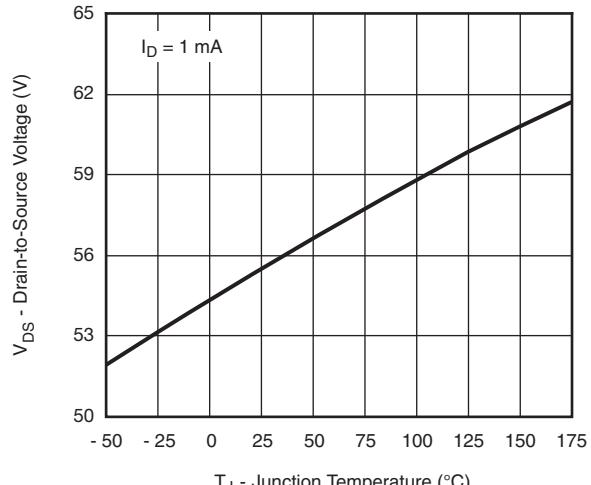
Source Drain Diode Forward Voltage



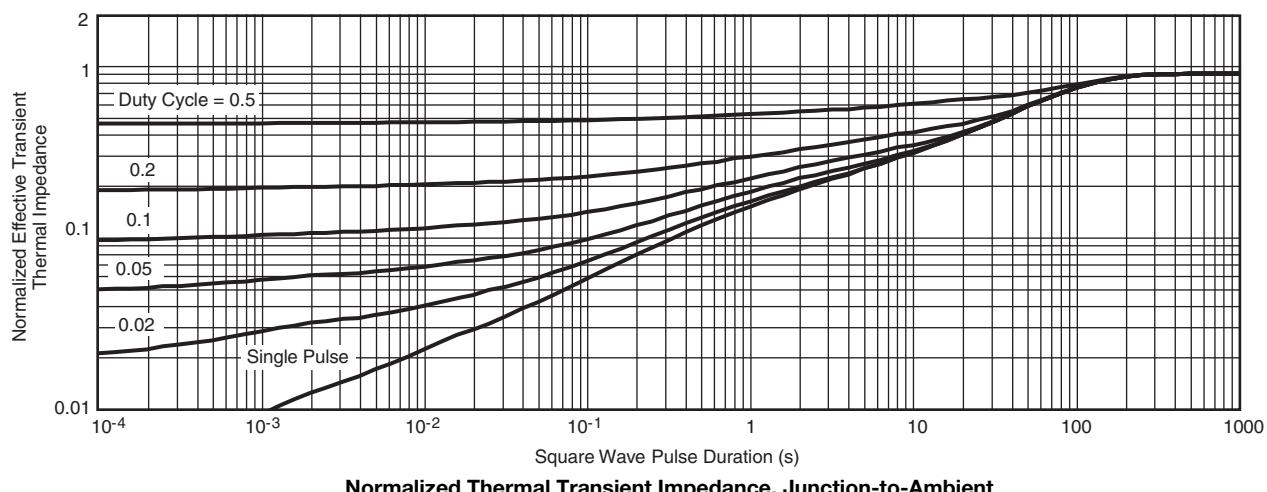
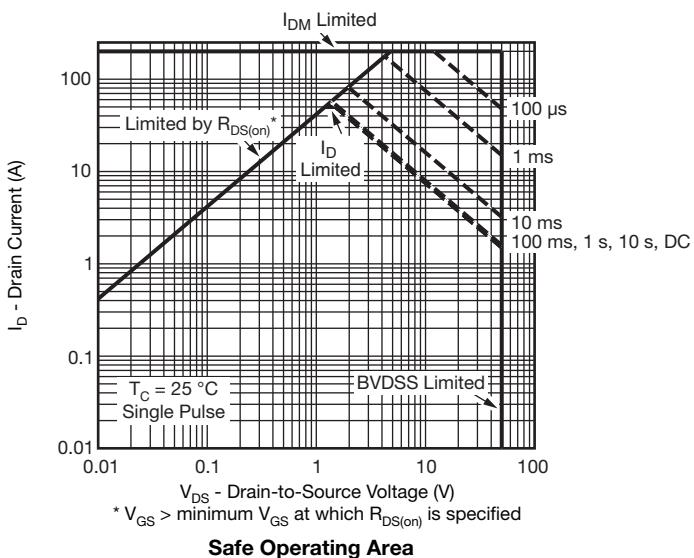
On-Resistance vs. Gate-to-Source Voltage

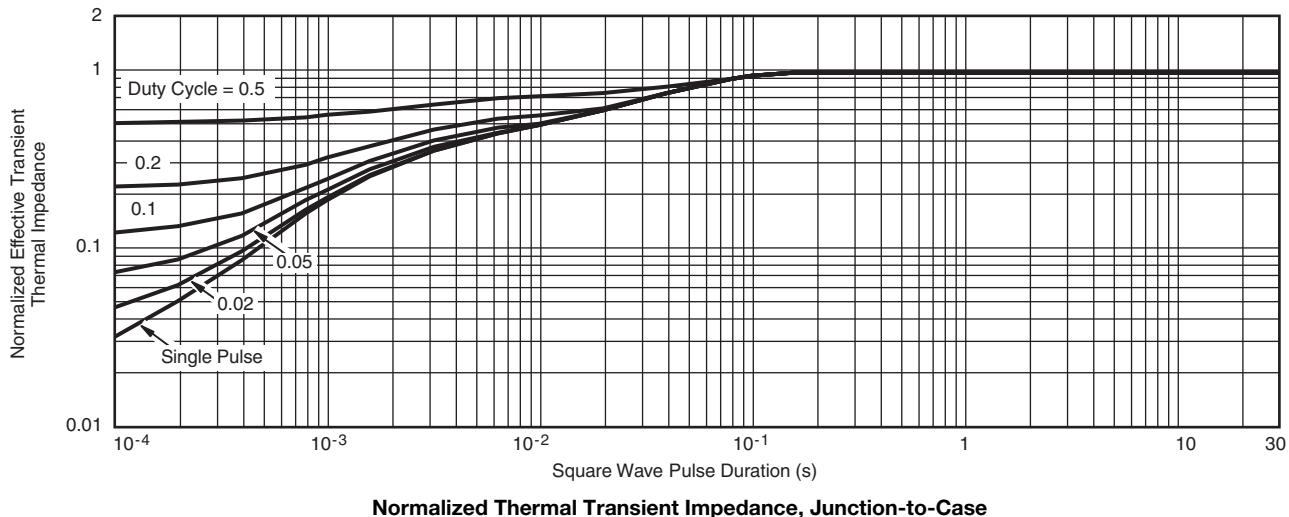


Threshold Voltage



Drain Source Breakdown vs. Junction Temperature

**THERMAL RATINGS** ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)


**THERMAL RATINGS** ( $T_A = 25^\circ\text{C}$ , unless otherwise noted)**Normalized Thermal Transient Impedance, Junction-to-Case****Note**

- The characteristics shown in the two graphs
  - Normalized Transient Thermal Impedance Junction-to-Ambient ( $25^\circ\text{C}$ )
  - Normalized Transient Thermal Impedance Junction-to-Case ( $25^\circ\text{C}$ )

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.

## **Disclaimer**

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